Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/829,583	CHEN ET AL.
Examiner	Art Unit
Leonardo Andújar	2826

SEARCHED				
Class	Subclass	Date	Examiner	
	 :			

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
257/690-799 (text serach only-see search history print out)	5/11/2006	LA	